

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10764569	MOTOYAMA ET AL.
Examiner	Art Unit	
Hoang, Hieu T	2452	

SEARCHED

Class	Subclass	Date	Examiner
709	223, 224	1/15/2008	HH

SEARCH NOTES

Search Notes	Date	Examiner
EAST	1/15/2008	HH
NPL (Google, IETF)	1/15/2008	HH
Updated EAST	5/27/2009	HH
Consulted with Kenny Lin on allowance	5/19/2009	HH
NPL (Google, IEEE)	5/27/2009	HH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
interference claim search		5/27/2009	HH